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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Applicant:

S. MARK HAUGLAND

February 28, 2002

Serial No.:

Unknown

METHOD OF DETERMINING **RESISTIVITY AND/OR**

DIELECTRIC VALUES OF AN EARTH FORMATION AS A **FUNCTION OF POSITION WITHIN**

THE EARTH FORMATION

Confirmation No.:

Art Unit:

Examiner:

Docket No.:

H052722.0029US0

INFORMATION DISCLOSURE STATEMENT

BOX PATENT APPLICATION

Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Filed:

For:

Applicant hereby submits the following references in accordance with 37 C.F.R. §§ 1.56 and 1.97. Copies of the references cited in the attached PTO-1449 are enclosed.

Respectfully submitted,

George W. Jordan MI, Reg. No. 41,880 ATTORNEY OR AGENT OF RECORD

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052722.0029 HOUSTON 225577 v1

Substitute for form 1449	A/PTO	Complete if Known		
		Application Number		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Filing Date		
		First Named Inventor	S. Mark Haugland	
4		Group Art Unit		
(use as many sheets as necessary)		Examiner Name		4 5
Sheet 1 c	of 2	Attorney Docket Number	H052722.0029US	Ü

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Signature	 Considered	
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